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Fault-Tolerant Computing, 1991. FTCS-21. Digest of Papers.,
Twenty-First International Symposium , 25-27 Jun 1991
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[Abstract]   [PDF Full-Text (1012 KB)] **IEEE CNF**

2 **RAPID-Cache-A reliable and inexpensive write cache for high performance storage systems**
Yiming Hu; Nightingale, T.; Qing Yang;
Parallel and Distributed Systems, IEEE Transactions on , Volume: 13
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Triantafillou, P.; Neilson, C.;
Software Engineering, IEEE Transactions on , Volume: 23 Issue: 1 ,
Jan 1997
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1 RAPID-Cache-a reliable and inexpensive write cache for disk I/O systems
Yiming Hu; Qing Yang; Nightingale, T.;
High-Performance Computer Architecture, 1999. Proceedings. Fifth International Symposium On , 9-13 Jan 1999
Page(s): 204 -213

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2 RAPID-Cache-A reliable and inexpensive write cache for high performance storage systems
Yiming Hu; Nightingale, T.; Qing Yang;
Parallel and Distributed Systems, IEEE Transactions on , Volume: 13 Issue: 3 , Mar 2002
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